

Notice of References Cited	Application/Control No. 10/718,179	Applicant(s)/Patent Under Reexamination TALLEY ET AL.	
	Examiner CHAN S. PARK	Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0093384	05-2003	Durst et al.	705/64
*	C	US-2002/0054778	05-2002	Ericson et al.	400/76
*	D	US-7,130,066	10-2006	Kanematu, Shinichi	358/1.15
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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